

<b>Notice of References Cited</b>	Application/Control No. 10/668,710		Applicant(s)/Patent Under Reexamination BUTLER, WALKER	
	Examiner Tai T. Nguyen		Art Unit 2632	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,812,450	11-2004	Hipp, Johann	250/221
*	C	US-6,664,918	12-2003	Paradie et al.	342/70
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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